Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/820,146	NISHIYAMA, NAOKI	
Examiner	Art Unit	
Davienne Monbleau	2878	

Davienne Monbleau

SEARCHED				
Class	Subclass	Date	Examiner	
250	214r 214ag	2/10/2006	DM	
327	514			
398	202			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
updated search EAST- USPGPUB, USPAT, EPO, JPO, DERWENT	2/10/2006	DM		
consulted with Stephone Allen AU 2878	2/9/2006	DM		
consulted with Thanh Lu AU 2878	2/10/2006	DM		